N-Channel Power MOSFET 100 V, 32 A, 37 m Ω

Features

- Low R_{DS(on)}
- High Current Capability
- 100% Avalanche Tested
- NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC–Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = $25^{\circ}C$ unless otherwise noted)

				,	
Para	meter		Symbol	Value	Unit
Drain-to-Source Voltage		V _{DSS}	100	V	
Gate-to-Source Voltage - Continuous			V _{GS}	±20	V
Continuous Drain	, ,	T _C = 25°C	I _D	32	А
Current R _{0JC}	State	$T_{C} = 100^{\circ}C$		22	
Power Dissipation $R_{\theta JC}$	Steady State	T _C = 25°C	P _D	100	W
Pulsed Drain Current	t _p :	= 10 μs	I _{DM}	117	А
Operating and Storage Temperature Range			T _J , T _{stg}	–55 to +175	°C
Source Current (Body Diode)			۱ _S	32	А
Single Pulse Drain-to-Source Avalanche Energy (V _{DD} = 50 Vdc, V _{GS} = 10 Vdc, $I_{L(pk)} = 32 \text{ A}, L = 0.3 \text{ mH}, R_G = 25 \Omega$)			E _{AS}	154	mJ
Lead Temperature for Soldering Purposes, 1/8" from Case for 10 Seconds			ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Case (Drain) Steady State	R_{\thetaJC}	1.5	°C/W
Junction-to-Ambient (Note 1)	$R_{\theta JA}$	37	

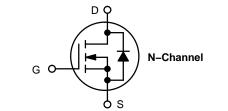
1. Surface mounted on FR4 board using 1 sq in pad size, (Cu Area 1.127 sq in [1 oz] including traces).

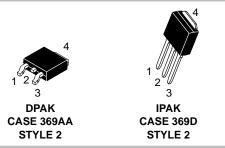


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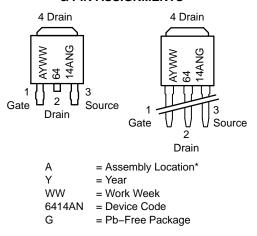
http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX (Note 1)
100 V	37 mΩ @ 10 V	32 A





MARKING DIAGRAM & PIN ASSIGNMENTS



* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 V, I_{D} = 250 \mu A$		100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				107		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 100 V	$T_{J} = 25^{\circ}C$ $T_{J} = 125^{\circ}C$			1.0 100	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} =	±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 2$	250 μA	2.0		4.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				8.3		mV/°C
Drain-to-Source On-Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D =	32 A		30	37	mΩ
Forward Transconductance	gFS	V _{GS} = 5.0 V, I _D = 10 A			18		S
CHARGES, CAPACITANCES AND GAT	E RESISTANC	E					
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 25 V			1450		pF
Output Capacitance	C _{OSS}				230		1
Reverse Transfer Capacitance	C _{RSS}				95		
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 10 V, V_{DS} = 80 V, I_{D} = 32 A			40		nC
Threshold Gate Charge	Q _{G(TH)}				1.7		
Gate-to-Source Charge	Q _{GS}				8.0		
Gate-to-Drain Charge	Q _{GD}				20		
Plateau Voltage	V _{GP}				5.9		V
Gate Resistance	R _G				1.9		Ω
SWITCHING CHARACTERISTICS (Note	e 4)						
Turn-On Delay Time	t _{d(on)}				11		ns
Rise Time	t _r	י חסע Vgs = 10 V. V	= 80 V.		52		
Turn–Off Delay Time	t _{d(off)}	V_{GS} = 10 V, V_{DD} = 80 V, I _D = 32 A, R _G = 6.1 Ω			38		
Fall Time	t _f				48		-
DRAIN-SOURCE DIODE CHARACTER	ISTICS						
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 \text{ V}, \text{ I}_{S} = 32 \text{ A}$ $T_{J} = 25^{\circ}\text{C}$ $T_{J} = 125^{\circ}\text{C}$			0.87	1.2	V
					0.76		1
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dl _S /dt = 100 A/μs, I _S = 32 A			68		ns
Charge Time	Ta				51		1
Discharge Time	Т _b				16		1

2E°C uplose otherwise noted) ELECTRICAL CHARACTERISTICS /T

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 2. Surface mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).

195

nC

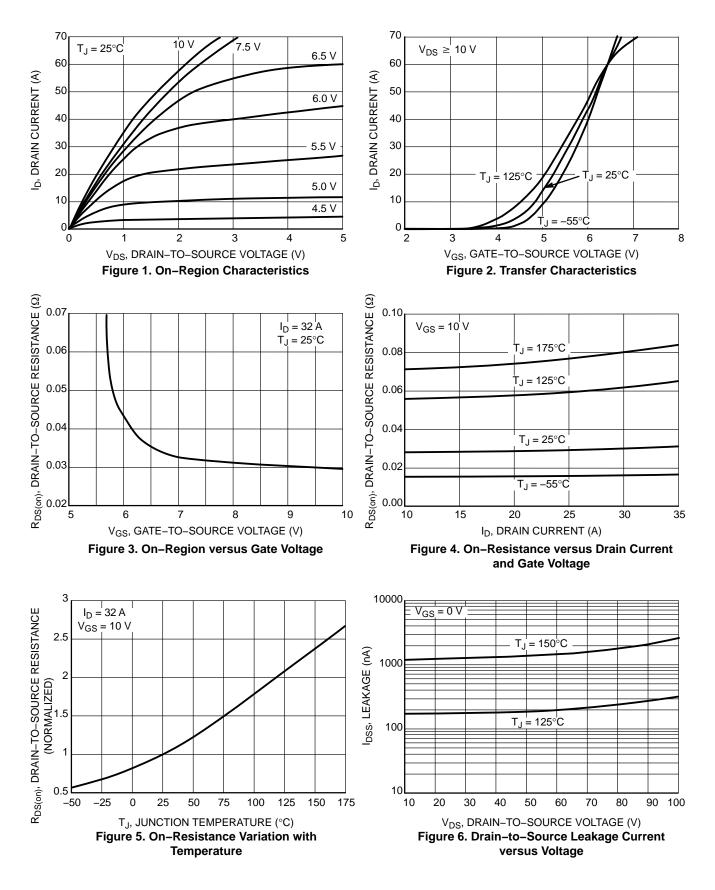
Q_{RR}

3. Pulse Test: Pulse Width \leq 300 µs, Duty Cycle \leq 2%.

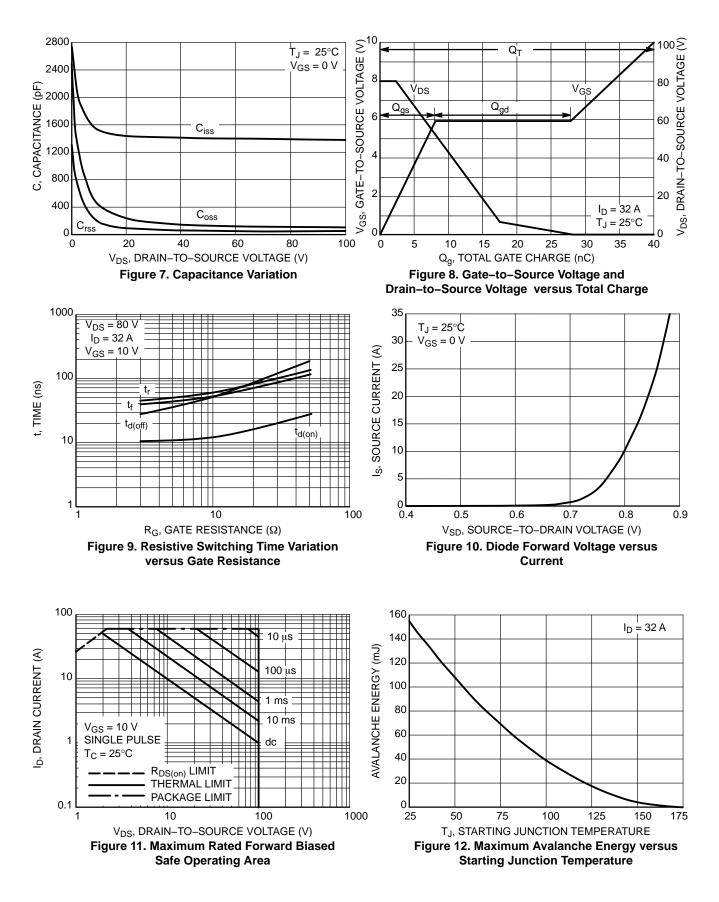
Reverse Recovery Charge

4. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

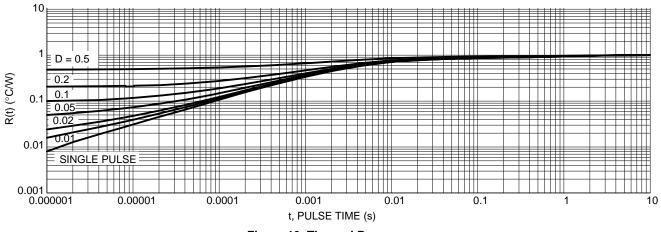


Figure 13. Thermal Response

ORDERING INFORMATION

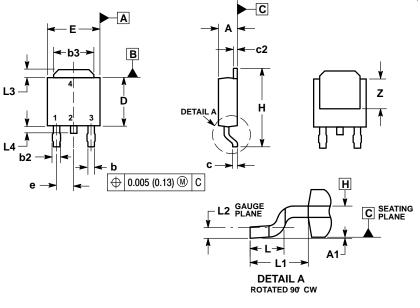
Device	Package	Shipping†
NTD6414ANT4G	DPAK (Pb–Free)	2500 / Tape & Reel
NTD6414AN–1G	IPAK (Pb–Free)	75 Units / Rail
NVD6414ANT4G*	DPAK (Pb–Free)	2500 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

*NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC–Q101 Qualified and PPAP Capable.

PACKAGE DIMENSIONS

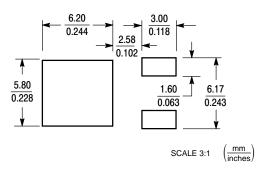
DPAK (SINGLE GUAGE) CASE 369AA **ISSUE B**



- NOTES: 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. 2. CONTROLLING DIMENSION: INCHES.
- CONTROLLING DIMENSION: INCHES.
 THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
 DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
 DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
 DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.
- PLANE H.

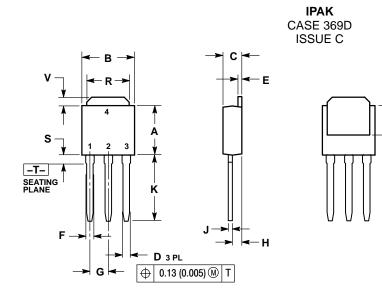
	INCHES		MILLIMETERS			
DIM	MIN	MAX	MIN	MAX		
Α	0.086	0.094	2.18	2.38		
A1	0.000	0.005	0.00	0.13		
b	0.025	0.035	0.63	0.89		
b2	0.030	0.045	0.76	1.14		
b3	0.180	0.215	4.57	5.46		
С	0.018	0.024	0.46	0.61		
c2	0.018	0.024	0.46	0.61		
D	0.235	0.245	5.97	6.22		
Е	0.250	0.265	6.35	6.73		
е	0.090	BSC	2.29 BSC			
н	0.370	0.410	9.40	10.41		
L	0.055	0.070	1.40	1.78		
L1	0.108	REF	2.74	2.74 REF		
L2	0.020	BSC	0.51 BSC			
L3	0.035	0.050	0.89	1.27		
L4		0.040		1.01		
Z	0.155		3.93			
STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN						

SOLDERING FOOTPRINT*



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS



NOTES:

Ζ

DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: INCH.

	INCHES		MILLIN	ETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.35	
В	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
Е	0.018	0.023	0.46	0.58	
F	0.037	0.045	0.94	1.14	
G	0.090 BSC		2.29 BSC		
н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
κ	0.350	0.380	8.89	9.65	
R	0.180	0.215	4.45	5.45	
S	0.025	0.040	0.63	1.01	
V	0.035	0.050	0.89	1.27	
Ζ	0.155		3.93		

STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE DRAIN 4

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